

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/646,307	BABICH ET AL.	
Examiner	Art Unit	
Sin J. Lee	1752	

SEARCHED					
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
■ EAST TEXT Search in USPAT \$ US-PGPUB (All Search History Printout)	10-13 -2005	B		
Structure Search on the formula shown on pg.4 of present spec.	9-28 -05	27 L		